

Features:

- Advanced trench process technology
- Ultra low $R_{ds(on)}$, typical 6mohm
- High avalanche energy, 100% test
- Fully characterized avalanche voltage and current

Description:

The SSF5508 is a new generation of middle voltage and high current N-Channel enhancement mode trench power MOSFET. This new technology increases the device reliability and electrical parameter repeatability. SSF5508 is assembled in high reliability and qualified assembly house.

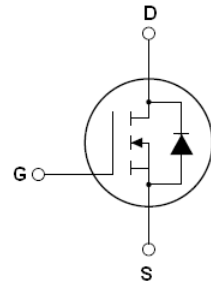
Application:

- Power switching application

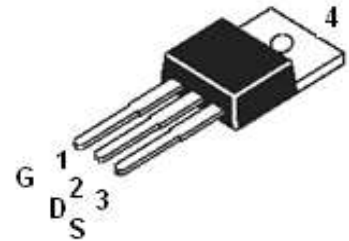
ID =110A

BV=55V

R_{ds(on)}=4.5 mΩ(typ.)



SSF5508 TOP View (TO220)



Absolute Maximum Ratings

	Parameter	Max.	Units
$I_D@T_c=25\text{ C}$	Continuous drain current, $V_{GS}@10V$	110	A
$I_D@T_c=100\text{ C}$	Continuous drain current, $V_{GS}@10V$	80	
I_{DM}	Pulsed drain current ①	400	
$P_D@T_c=25\text{ C}$	Power dissipation	170	W
	Linear derating factor	2.0	W/ C
V_{GS}	Gate-to-Source voltage	± 20	V
dv/dt	Peak diode recovery voltage	31	v/ns
E_{AS}	Single pulse avalanche energy ②	480	mJ
E_{AR}	Repetitive avalanche energy	TBD	
T_J T_{STG}	Operating Junction and Storage Temperature Range	-55 to +150	°C

Thermal Resistance

	Parameter	Min.	Typ.	Max.	Units
$R_{\theta JC}$	Junction-to-case	—	0.73	—	C/W
$R_{\theta JA}$	Junction-to-ambient	—	—	62	

Electrical Characteristics @ $T_J=25\text{ C}$ (unless otherwise specified)

	Parameter	Min.	Typ.	Max.	Units	Test Conditions
BV_{DSS}	Drain-to-Source breakdown voltage	55	—	—	V	$V_{GS}=0V, I_D=250\mu A$
$R_{DS(on)}$	Static Drain-to-Source on-resistance	—	4.5	8	mΩ	$V_{GS}=10V, I_D=68A$
$V_{GS(th)}$	Gate threshold voltage	2.0	—	4.0	V	$V_{DS}=V_{GS}, I_D=250\mu A$
g_{fs}	Forward transconductance	-	58	—	S	$V_{DS}=5V, I_D=30A$
I_{DSS}	Drain-to-Source leakage current	—	—	2	μA	$V_{DS}=55V, V_{GS}=0V$
		—	—	10		$V_{DS}=55V, V_{GS}=0V, T_J=150\text{ C}$
I_{GSS}	Gate-to-Source forward leakage	—	—	100	nA	$V_{GS}=20V$